# 6N139, 6N138, HCPL-0701, HCPL-0700, HCNW139, HCNW-138 

## Low Input Current, High Gain Optocouplers

## Data Sheet

 $-x x x E$ denotes a lead-free product
## Description

These high gain series couplers use a Light Emitting Diode and an integrated high gain photodetector to provide extremely high current transfer ratio between input and output. Separate pins for the photodiode and output stage result in TTL compatible saturation voltages and high speed operation. Where desired the $V_{C C}$ and $V_{O}$ terminals may be tied together to achieve conventional photodarlington operation. A base access terminal allows a gain bandwidth adjustment to be made.

The 6N139, HCPL-0701, and CNW139 are for use in CMOS, LSTTL or other low power applications. A $400 \%$ minimum current transfer ratio is guaranteed over 0 to $70^{\circ} \mathrm{C}$ operating range for only 0.5 mA of LED current.

The 6N138, HCPL-0700, and HCNW138 are designed for use mainly in TTL applications. Current Transfer Ratio (CTR) is $300 \%$ minimum over 0 to $70^{\circ} \mathrm{C}$ for an LED current of 1.6 mA ( 1 TTL Unit load ). A 300\% minimum CTR enables operation with 1 TTL Load using a $2.2 \mathrm{k} \Omega$ pull-up resistor.

## Functional Diagram


TRUTH TABLE

| LED | $\mathrm{V}_{\mathbf{O}}$ |
| :---: | :---: |
| ON | LOW |
| OFF | HIGH |

*5000 V rms/1 minute rating is for HCNW139/138 and Option 020 (6N139/138) products only.
A $0.1 \mu \mathrm{~F}$ bypass capacitor connected between pins 8 and 5 is recommended.

## Features

- High current transfer ratio - 2000\% typical (4500 \% typical for HCNW139/138)
- Low input current requirements -0.5 mA
- TTL compatible output - $0.1 \mathrm{~V} \mathrm{~V}_{\text {oL }}$ typical
- Performance guaranteed over temperature $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$
- Base access allows gain bandwidth adjustment
- High output current - 60 mA
- Safetyapproval

UL recognized - 3750 V rms for 1 minute and 5000 V rms* for 1 minute per UL 1577
CSA approved
IEC/EN/DIN EN 60747-5-2 approved with $\mathrm{V}_{\text {IORM }}=1414$ $V_{\text {peak }}$ for HCNW139 and HCNW138

- Available in 8-Pin DIP or SOIC-8 footprint or widebody package
- MIL-PRF-38534 hermetic version available (HCPL-5700/1)


## Applications

- Ground isolate most logic families - TTL/TTL, CMOS/ TTL, CMOS/CMOS, LSTTL/TTL, CMOS/LSTTL
- Low input current line receiver
- High voltage insulation (HCNW139/138)
- EIA RS-232C line receiver
- Telephone ring detector
- 117 V ac line voltage status indicator - low input power dissipation
- Low power systems - ground isolation

Selection for lower input current down to $250 \mu \mathrm{~A}$ is available upon request.

The HCPL-0701 and HCPL-0700 are surface mount devices packaged in an industry standard SOIC-8 footprint.

The SOIC-8 does not require "through holes" in a PCB. This package occupies approximately one-third the footprint area of the standard dual-in-line package. The
lead profile is designed to be compatible with standard surface mount processes.

The HCNW139 and HCNW138 are packaged in a widebody encapsulation that provides creepage and clearance dimensions suitable for safety approval by regulatory agencies worldwide.

Selection Guide

| $\begin{aligned} & \text { 8-Pin DIP } \\ & \text { (300 Mil) } \end{aligned}$ |  | Small Outline S0-8 |  | Widebody <br> Package <br> (400 mil) <br>  <br> Single <br> Channel <br> Package | Minimum Input ON Current ( ${ }_{\mathrm{F}}$ ) | Minimum CTR | Absolute Maximum $V_{c c}$ | Hermetic |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Single and |  |  |  |  |
| Single <br> Channel <br> Package | Dual <br> Channel Package HCPL- |  |  | Single Channel Package HCPL- |  |  |  | $\begin{gathered} \text { Dual } \\ \text { Channel } \\ \text { Package } \\ \text { HCPL- } \end{gathered}$ | Dual <br> Channel Packages HCPL- |
| 6N139 | $2731{ }^{[1]}$ | 0701 | 0731 |  | HCNW139 | 0.5 mA | 400\% | 18 V |  |
| 6N138 | $273{ }^{[1]}$ | 0700 | 0730 | HCNW138 | 1.6 mA | 300\% | 7 V |  |
| HCPL-4701 ${ }^{[1]}$ | $4731{ }^{[1]}$ | $070 \mathrm{~A}^{[1]}$ | $073 A^{[1]}$ |  | $40 \mu \mathrm{~A}$ | 800\% | 18 V |  |
|  |  |  |  |  | 0.5 mA | 300\% | 20 V | $5701^{[1]}$ $5700^{[1]}$ $5731^{[1]}$ $5730^{[1]}$ |

Note:

1. Technical data are on separate Avago publications.

## Ordering Information

6N138, 6N139, HCPL-0700 and HCPL-0701 are UL Recognized with 3750 Vrms for 1 minute per UL1577 and are approved under CSA Component Acceptance Notice \#5, File CA 88324.

| Part <br> Number | Option |  | Package | Surface <br> Mount | Gull <br> Wing | Tape \& Reel | UL 5000 Vrms/ 1 Minute rating | IEC/EN/DINEN 60747-5-2 | Quantity |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | RoHS <br> Compliant | non RoHS <br> Compliant |  |  |  |  |  |  |  |
| $\begin{aligned} & \text { 6N138 } \\ & \text { 6N139 } \end{aligned}$ | -000E | no option | 300 mil DIP-8 |  |  |  |  |  | 50 per tube |
|  | -300E | \#300 | 300 mil DIP-8 | X | X |  |  |  | 50 per tube |
|  | -500E | \#500 | 300 mil DIP-8 | X | X | X |  |  | 1000 per reel |
|  | -020E | \#020 | 300 mil DIP-8 |  |  |  | X |  | 50 per tube |
|  | -320E | \#320 | 300 mil DIP-8 | X | X |  | X |  | 50 per tube |
|  | -520E | \#520 | 300 mil DIP-8 | X | X | X | X |  | 1000 per reel |
|  | -060E | \#060 | 300 mil DIP-8 |  |  |  |  | X | 50 per tube |
|  | -360E | \#360 | 300 mil DIP-8 | X | X |  |  | X | 50 per tube |
|  | -560E | \#560 | 300 mil DIP-8 | X | X | X |  | X | 1000 per reel |
| HCPL-0700 <br> HCPL-0701 | -000E | no option | SO-8 |  |  |  |  |  | 100 per tube |
|  | -500E | \#500 | SO-8 | X | X | X |  |  | 1500 per reel |
|  | -060E | \#060 | SO-8 |  |  |  |  | X | 100 per tube |
|  | -560E | \#560 | SO-8 | X | X | X |  | X | 1500 per reel |
| HCNW138 <br> HCNW139 | -000E | no option | 400 mil <br> Widebody <br> DIP-8 |  |  |  |  |  | 42 per tube |
|  | -300E | \#300 |  | X | X |  |  |  | 42 per tube |
|  | -500E | \#500 |  | X | X | X |  |  | 750 per reel |

To order, choose a part number from the part number column and combine with the desired option from the option column to form an order entry.

Example 1:
6N138-560E to order product of 300 mil DIP Gull Wing Surface Mount package in Tape and Reel packaging with IEC/EN/DIN EN 60747-5-2 Safety Approval and RoHS compliant.

Example 2:
HCPL-0700 to order product of 300 mil DIP package in Tube packaging and non RoHS compliant.

Option datasheets are available. Contact your Avago sales representative or authorized distributor for information.

Remarks: The notation ' $\# X X X$ ' is used for existing products, while (new) products launched since July 15, 2001 and RoHS compliant will use'-XXXE.'

## Schematic



Package Outline Drawings
8-Pin DIP Package (6N139/6N138)**

**JEDEC Registered Data.

DIMENSIONS IN MILLIMETERS AND (INCHES). * MARKING CODE LETTER FOR OPTION NUMBERS "L" = OPTION 020
OPTION NUMBERS 300 AND 500 NOT MARKED.
NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm ( 10 mils ) MAX.

8-Pin DIP Package with Gull Wing Surface Mount Option 300 (6N139/6N138)


## Small Outline S0-8 Package (HCPL-0701/HCPL-0700)



DIMENSIONS IN MILLIMETERS (INCHES)
LEAD COPLANARITY $=\mathbf{0 . 1 0 ~ m m ~ ( ~} 0.004$ INCHES) MAX.
NOTE: FLOATING LEAD PROTRUSION IS 0.15 mm ( $\mathbf{6}$ mils) MAX.

## 8-Pin Widebody DIP Package (HCNW139/HCNW138)



NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm ( 10 mils ) MAX.


## Solder Reflow Temperature Profile



NOTE: NON-HALIDE FLUX SHOULD BE USED.

## Recommended Pb-Free IR Profile



## Regulatory Information

The 6N139/138, HCNW139/138, and HCPL-0701/0700 have been approved by the following organizations:

UL
Recognized under UL 1577, Component Recognition Program, File E55361.

CSA
Approved under CSA Component Acceptance Notice \#5, File CA 88324.

IEC/EN/DIN EN 60747-5-2
Approved under
IEC 60747-5-2:1997 + A1:2002
EN 60747-5-2:2001 + A1:2002
DIN EN 60747-5-2 (VDE 0884 Teil 2):2003-01
(HCNW139/138 only)

Insulation and Safety Related Specifications

| Parameter | Symbol | 8-Pin DIP (300 Mil) Value | S0-8 <br> Value | Widebody <br> ( 400 Mil ) <br> Value | Units | Conditions |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Minimum External Air Gap (External Clearance) | L(101) | 7.1 | 4.9 | 9.6 | mm | Measured from input terminals to output terminals, shortest distance through air. |
| Minimum External Tracking (External Creepage) | L(102) | 7.4 | 4.8 | 10.0 | mm | Measured from input terminals to output terminals, shortest distance path along body. |
| Minimum Internal Plastic Gap (Internal Clearance) |  | 0.08 | 0.08 | 1.0 | mm | Through insulation distance, conductor to conductor, usually the direct distance between the photoemitter and photodetector inside the optocoupler cavity. |
| Minimum Internal Tracking (Internal Creepage) |  | NA | NA | 4.0 | mm | Measured from input terminals to output terminals, along internal cavity. |
| Tracking Resistance (Comparative Tracking Index) | CTI | 200 | 200 | 200 | Volts | DIN IEC 112/VDE 0303 Part 1 |
| Isolation Group |  | IIIa | Illa | Illa |  | Material Group <br> (DIN VDE 0110, 1/89, Table 1) |

Option 300 - surface mount classification is Class A in accordance with CECC 00802.

IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics (HCNW139 and HCNW138)

| Description | Symbol | Characteristic | Units |
| :---: | :---: | :---: | :---: |
| Installation Classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage $\leq 600 \mathrm{~V}$ rms |  | I-IV |  |
| for rated mains voltage $\leq 1000 \mathrm{~V}$ rms |  | I-III |  |
| Climatic Classification |  | 55/100/21 |  |
| Pollution Degree (DIN VDE 0110/1.89) |  | 2 |  |
| Maximum Working Insulation Voltage | $\mathrm{V}_{\text {IORM }}$ | 1414 | $\mathrm{V}_{\text {peak }}$ |
| Input to Output Test Voltage, Method b* <br> $V_{\text {PR }}=1.875 \times V_{\text {IORM' }} 100 \%$ Production Test with $t_{p}=1 \mathrm{sec}$, <br> Partial Discharge $<5 \mathrm{pC}$ | $V_{\text {PR }}$ | 2652 | $V_{\text {peak }}$ |
| Input to Output Test Voltage, Method a* <br> $\mathrm{V}_{\mathrm{PR}}=1.5 \times \mathrm{V}_{\text {IORM }}$, Type and Sample Test, <br> $\mathrm{t}_{\mathrm{p}}=60 \mathrm{sec}$, Partial Discharge $<5 \mathrm{pC}$ | $V_{\text {PR }}$ | 2121 | $V_{\text {peak }}$ |
| Highest Allowable Overvoltage* <br> (Transient Overvoltage, $\mathrm{t}_{\text {ini }}=10 \mathrm{sec}$ ) | $\mathrm{V}_{\text {Іотм }}$ | 8000 | $V_{\text {peak }}$ |
| Safety Limiting Values <br> (Maximum values allowed in the event of a failure, also see Figure 11, Thermal Derating curve.) <br> Case Temperature <br> Current (Input Current $\mathrm{I}_{\mathrm{F}}, \mathrm{P}_{\mathrm{s}}=0$ ) <br> Output Power |  | $\begin{array}{r} 175 \\ 400 \\ 700 \\ \hline \end{array}$ | ${ }^{\circ} \mathrm{C}$ <br> mA <br> mW |
| Insulation Resistance at $\mathrm{T}_{\mathrm{S}^{\prime}} \mathrm{V}_{10}=500 \mathrm{~V}$ | $\mathrm{R}_{\mathrm{s}}$ | $>10^{9}$ | $\Omega$ |

*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section, IEC/EN/DIN EN 60747-5-2, for a detailed description.
Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

Absolute Maximum Ratings* (No Derating Required up to $85^{\circ} \mathrm{C}$ )

| Parameter | Symbol | Min. | Max. | Units |
| :---: | :---: | :---: | :---: | :---: |
| Storage Temperature | $\mathrm{T}_{5}$ | -55 | 125 | ${ }^{\circ} \mathrm{C}$ |
| Operating Temperature** | $\mathrm{T}_{\mathrm{A}}$ | -40 | 85 | ${ }^{\circ} \mathrm{C}$ |
| Average Forward Input Current | $\mathrm{I}_{\text {FAVG) }}$ |  | 20 | mA |
| Peak Forward Input Current (50\% Duty Cycle, 1 ms Pulse Width) | $\mathrm{I}_{\text {FPK }}$ |  | 40 | mA |
| Peak Transient Input Current ( $<1 \mu \mathrm{~s}$ Pulse Width, 300 pps ) | $\mathrm{If}_{\text {(tRAN }}$ |  | 1.0 | A |
| Reverse Input Voltage | $V_{\text {R }}$ |  | 5 | V |
| HCNW139/138 |  |  | 3 | V |
| Input Power Dissipation | $\mathrm{P}_{1}$ |  | 35 | mW |
| Output Current (Pin 6) | 10 |  | 60 | mA |
| Emitter Base Reverse Voltage (Pin 5-7) | $\mathrm{V}_{\text {EB }}$ |  | 0.5 | V |
| Supply Voltage and Output Voltage (6N139, HCPL-0701, HCNW139) | $\mathrm{V}_{\text {cc }}$ | -0.5 | 18 | V |
| Supply Voltage and Output Voltage (6N138, HCPL-0700, HCNW138) | $\mathrm{V}_{\text {cc }}$ | -0.5 | 7 | V |
| Output Power Dissipation | Po |  | 100 | mW |
| Total Power Dissipation | $\mathrm{P}_{\text {T }}$ |  | 135 | mW |
| Lead Solder Temperature (for Through Hole Devices) | $260^{\circ} \mathrm{C}$ for $10 \mathrm{sec} ., 1.6 \mathrm{~mm}$ below seating plane |  |  |  |
| HCNW139/138 | $260^{\circ} \mathrm{C}$ for 10 sec ., up to seating plane |  |  |  |
| Reflow Temperature Profile (for SOIC-8 and Option \#300) | See Package Outline Drawings section |  |  |  |

*JEDEC Registered Data for 6N139 and 6N138.
${ }^{* *} 0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ on JEDEC Registration.

## Recommended Operating Conditions

| Parameter | Symbol | Min. | Max. | Units |
| :--- | :---: | :---: | :---: | :---: |
| Power Supply Voltage | $\mathrm{V}_{\mathrm{CC}}$ | 4.5 | 18 | V |
| Forward Input Current (ON) | $\mathrm{I}_{\text {F(ON) }}$ | 0.5 | 12.0 | mA |
| Forward Input Voltage (OFF) | $\mathrm{V}_{\text {F(OFF) }}$ | 0 | 0.8 | V |
| Operating Temperature | $\mathrm{T}_{\mathrm{A}}$ | 0 | 70 | ${ }^{\circ} \mathrm{C}$ |

## Electrical Specifications

$0^{\circ} \mathrm{C} \leq \mathrm{T}_{\mathrm{A}} \leq 70^{\circ} \mathrm{C}, 4.5 \mathrm{~V} \leq \mathrm{V}_{C \mathrm{C}} \leq 18 \mathrm{~V}, 0.5 \mathrm{~mA} \leq \mathrm{I}_{\mathrm{F}(\mathrm{ON})} \leq 12 \mathrm{~mA}, 0 \mathrm{~V} \leq \mathrm{V}_{\text {F(OFF) }} \leq 0.8 \mathrm{~V}$, unless otherwise specified.
All Typicals at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$. See Note 7 .

*JEDEC Registered Data for 6N139 and 6N138.
${ }^{* *}$ All typical values at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ and $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$, unless otherwise noted.

## Switching Specifications (AC)

Over recommended operating conditions ( $T_{\mathrm{A}}=0$ to $\left.70^{\circ} \mathrm{C}\right), \mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$, unless otherwise specified.

| Parameter | Sym. | Device | Min. | Typ.** | $\begin{array}{r} \text { Max. } \\ \hline \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \end{array}$ |  | Units | Test Conditions | Fig. | Note |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Propagation Delay Time to Logic Low | $\mathrm{t}_{\text {PHL }}$ | $\begin{gathered} \text { 6N139 } \\ \text { HCPL-0701 } \\ \text { HCNW139 } \\ \hline \end{gathered}$ |  | 5 | 25* | 30 | $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=0.5 \mathrm{~mA}, \\ & \mathrm{RI}=4.7 \mathrm{k} \Omega \end{aligned}$ | $\begin{gathered} 5,6, \\ 7,9, \\ 12 \end{gathered}$ | 2,4 |
| at Output |  | $\begin{gathered} \text { 6N139 } \\ \text { HCPL-0701 } \\ \hline \end{gathered}$ |  | 0.2 | 1* | 2 | $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=12 \mathrm{~mA}, \\ & \mathrm{RI}=270 \Omega \end{aligned}$ |  |  |
|  |  | HCNW139 |  |  |  | 11 |  |  |  |  |
|  |  | $\begin{gathered} \text { 6N138 } \\ \text { HCPL-0700 } \\ \hline \end{gathered}$ |  | 1.6 | 10* | 15 | $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=1.6 \mathrm{~mA}, \\ & \mathrm{RI}=2.2 \mathrm{k} \Omega \end{aligned}$ |  |  |
|  |  | HCNW138 |  |  |  | 11 |  |  |  |  |
| Propagation Delay Time | $t_{\text {PLH }}$ | $\begin{gathered} \text { 6N139 } \\ \text { HCPL-0701 } \\ \hline \end{gathered}$ |  | 18 | 60* | 90 | $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=0.5 \mathrm{~mA}, \\ & \mathrm{RI}=4.7 \mathrm{k} \Omega \end{aligned}$ | $\begin{gathered} 5,6, \\ 7,9, \\ 12 \end{gathered}$ | 2,4 |
| to Logic High |  | HCNW139 |  |  |  | 115 |  |  |  |  |
| at Output |  | $\begin{gathered} \text { 6N139 } \\ \text { HCPL-0701 } \end{gathered}$ |  | 2 | 7* | 10 | $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=12 \mathrm{~mA}, \\ & \mathrm{RI}=270 \Omega \end{aligned}$ |  |  |
|  |  | HCNW139 |  |  |  | 11 |  |  |  |  |
|  |  | $\begin{gathered} \text { 6N138 } \\ \text { HCPL-0700 } \end{gathered}$ |  | 10 | 35* | 50 | $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=1.6 \mathrm{~mA}, \\ & \mathrm{RI}=2.2 \mathrm{k} \Omega \end{aligned}$ |  |  |
|  |  | HCNW138 |  |  |  | 70 |  |  |  |  |
| Common Mode <br> Transient <br> Immunity at <br> Logic High <br> Output | $\left\|\mathrm{CM}_{\mathrm{H}}\right\|$ |  | 1000 | 10000 |  |  | V/ $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=0 \mathrm{~mA}, \\ & \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \\ & \mathrm{RI}=2.2 \mathrm{k} \Omega \\ & \left\|\mathrm{~V}_{\mathrm{CM}}\right\|=10 \\ & \mathrm{Vp}-\mathrm{p} \\ & \hline \end{aligned}$ | 13 | 5,6 |
| Common Mode <br> Transient Immunity at Logic Low Output | $\left\|\mathrm{CM}_{\llcorner }\right\|$ |  | 1000 | 10000 |  |  | V/ $\mu \mathrm{s}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=1.6 \mathrm{~mA}, \\ & \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \\ & \mathrm{RI}=2.2 \mathrm{k} \Omega \\ & \left\|\mathrm{~V}_{\mathrm{CM}}\right\|=10 \\ & \mathrm{Vp}-\mathrm{p} \end{aligned}$ | 13 | 5,6 |

*JEDEC Registered Data for 6N139 and 6N138.
${ }^{* *}$ All typical values at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ and $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}$, unless otherwise noted.

## Package Characteristics

| Parameter | Sym. | Min. | Typ.** | Max. | Units | Test Conditions | Fig. | Note |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Input-Output Momentary Withstand Voltage $\dagger$ | $\mathrm{V}_{150}$ | 3750 |  |  | V rms | $\begin{aligned} & \mathrm{RH}<50 \%, \mathrm{t}=1 \mathrm{~min} ., \\ & \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \end{aligned}$ |  | 3, 8 |
| Option 020 HCNW139 HCNW138 |  | 5000 |  |  |  |  |  | 3,9 |
| Resistance (Input-Output) | $\mathrm{R}_{\text {-O }}$ |  | $10^{12}$ |  | $\Omega$ | $\begin{aligned} & \mathrm{V}_{\mathrm{I}-\mathrm{O}}=500 \mathrm{Vdc} \\ & \mathrm{RH}<45 \% \end{aligned}$ |  | 3 |
| Capacitance (Input-Output) | $\mathrm{C}_{1-\mathrm{O}}$ |  | 0.6 |  | pF | $\mathrm{f}=1 \mathrm{MHz}$ |  | 3 |

${ }^{* *}$ All typicals at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise noted.
$\dagger$ The Input-OutputMomentaryWithstandVoltage is a dielectric voltage rating thatshould notbeinterpretedasaninput-output continuous voltage rating. For the continuous voltage rating refer to the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table (if applicable), your equipment level safety specification or Avago Application Note 1074 entitled "Optocoupler Input-Output Endurance Voltage."

## Notes:

1. DC CURRENT TRANSFER RATIO (CTR) is defined as the ratio of output collector current, $I_{0}$, to the forward LED input current, $I_{F}$, times $100 \%$.
2. Pin 7 Open.
3. Device considered a two-terminal device. Pins $1,2,3$, and 4 shorted together and Pins $5,6,7$, and 8 shorted together.
4. Use of a resistor between pin 5 and 7 will decrease gain and delay time. Significant reduction in overall gain can occur when using resistor values below $47 \mathrm{k} \Omega$. For more information, please contact your local Avago Components representative.
5. Common mode transient immunity in a Logic High level is the maximum tolerable (positive) $d V^{C M} / \mathrm{dt}$ of the common mode pulse, $\mathrm{V}_{\mathrm{CM}}$, to assure that the output will remain in a Logic High state (i.e., $\mathrm{V}_{0}>2.0 \mathrm{~V}$ ). Common mode transient immunity in a Logic Low level is the maximum tolerable (negative) $\mathrm{dV}_{\mathrm{CM}} / \mathrm{dt}$ of the common mode pulse, $\mathrm{V}_{\mathrm{CM}}$, to assure that the output will remain in a Logic Low state (i.e., $\mathrm{V}_{\mathrm{O}}<0.8 \mathrm{~V}$ ).
6. In applications where $\mathrm{dV} / \mathrm{dt}$ may exceed $50,000 \mathrm{~V} / \mu \mathrm{s}$ (such as static discharge) a series resistor, Rcc, should be included to protect the detector IC from destructively high surge currents. The recommended value is $\mathrm{R}_{\mathrm{cc}}=220 \Omega$.
7. Use of a $0.1 \mu \mathrm{~F}$ bypass capacitor connected between pins 8 and 5 adjacent to the device is recommended.
8. In accordance with UL 1577 , each optocoupler is proof tested by applying an insulation test voltage 4500 V rms for 1 second (leakage detection current limit, $\mathrm{I}_{1-0}<5 \mu \mathrm{~A}$ ). This test is performed before the $100 \%$ production test shown in the IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics Table, if applicable.
9. In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage $>6000 \mathrm{~V}$ rms for 1 second (leakage detection current limit, $I_{1-0}<5 \mu \mathrm{~A}$ ). This test is performed before the $100 \%$ production test for partial discharge (method b) shown in the IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics Table, if applicable.


Figure 1. 6N138/6N139 DC transfer characteristics


Figure 4. Input diode forward current vs. forward voltage


Figure 2. Current transfer ratio vs. forward current 6N138/6N139


Figure 5. Propagation delay vs. temperature


Figure 8. Forward voltage vs. temperature


Figure 3. 6N138/6N139 output current vs. input diode forward current


Figure 6. Propagation delay vs. temperature


Figure 9. Nonsaturated rise and fall times vs. load resistance


Figure 10. Logic low supply current vs. forward current


Figure 11. Thermal derating curve, dependence of safety limiting value with case temperature per IEC/EN/DIN EN 60747-5-2


Figure 12. Switching test circuit


Figure 13. Test circuit for transient immunity and typical waveforms

For product information and a complete list of distributors, please go to our website: www.avagotech.com
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